

5.0 or 3.3V, 256 Kbit (32 Kb x8) TIMEKEEPER[®] SRAM

FEATURES SUMMARY

- INTEGRATED, ULTRA LOW POWER SRAM, REAL TIME CLOCK, POWER-FAIL CONTROL CIRCUIT AND BATTERY
- BYTEWIDE[™] RAM-LIKE CLOCK ACCESS
- BCD CODED YEAR, MONTH, DAY, DATE, HOURS, MINUTES, AND SECONDS
- BATTERY LOW FLAG (BOK)
- FREQUENCY TEST OUTPUT FOR REAL TIME CLOCK
- AUTOMATIC POWER-FAIL CHIP DESELECT AND WRITE PROTECTION
- WRITE PROTECT VOLTAGES
 (V_{PFD} = Power-fail Deselect Voltage):
 - M48T35AY: V_{CC} = 4.5 to 5.5V
 - $\label{eq:V_PFD} \begin{array}{l} 4.2 V \leq V_{PFD} \leq 4.5 V \\ & M48T35 AV: \ V_{CC} = 3.0 \ to \ 3.6 V \end{array}$
 - $2.7V \le V_{PFD} \le 3.0V$
- SELF-CONTAINED BATTERY AND CRYSTAL IN THE CAPHAT[™] DIP PACKAGE
- SOIC PACKAGE PROVIDES DIRECT CONNECTION FOR A SNAPHAT[®] HOUSING CONTAINING THE BATTERY AND CRYSTAL
- SNAPHAT[®] HOUSING (BATTERY AND CRYSTAL) IS REPLACEABLE
- PIN AND FUNCTION COMPATIBLE WITH JEDEC STANDARD 32Kb x8 SRAMs



Figure 2. 28-pin SOIC Package



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SUMMARY DESCRIPTION

The M48T35AY/V TIMEKEEPER[®] RAM is a 32Kb x 8 non-volatile static RAM and real time clock. The monolithic chip is available in two special packages to provide a highly integrated battery backed-up memory and real time clock solution.

The M48T35AY/V is a non-volatile pin and function equivalent to any JEDEC standard 32Kb x 8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special WRITE timing or limitations on the number of WRITEs that can be performed.

The 28-pin, 600mil DIP CAPHAT[™] houses the M48T35AY/V silicon with a quartz crystal and a long-life lithium button cell in a single package.

The 28-pin, 330mil SOIC provides sockets with gold plated contacts at both ends for direct con-

nection to a separate SNAPHAT[®] housing containing the battery and crystal. The unique design allows the SNAPHAT battery package to be mounted on top of the SOIC package after the completion of the surface mount process. Insertion of the SNAPHAT housing after reflow prevents potential battery and crystal damage due to the high temperatures required for device surfacemounting. The SNAPHAT housing is keyed to prevent reverse insertion.

The SOIC and battery/crystal packages are shipped separately in plastic anti-static tubes or in Tape & Reel form.

For the 28-lead SOIC, the battery/crystal package (e.g. SNAPHAT) part number is "M4T28-BR12SH" (see Table 17., page 23).



Table 1. Signal Names

A0-A14	Address Inputs			
DQ0-DQ7	Data Inputs / Outputs			
Ē	Chip Enable			
G	Output Enable			
W	WRITE Enable			
V _{CC}	Supply Voltage			
V _{SS}	Ground			

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Figure 4. DIP Connections								
A14 [A14 [A12] A7 [A6 [A5] A4 [A3] A2 [A1] A0 [DQ0 [DQ1 [DQ2 [VSS]	1 2 3 4 5 6 7	M48T35AY M48T35AV	25 24 23 22	VCC W A13 A8 A9 A11 G A10 E DQ7 DQ6 DQ5 DQ4 DQ3				
		AI027	798E	5				

Figure 5. SOIC Connections



Figure 6. Block Diagram



OPERATION MODES

As Figure 6., page 5 shows, the static memory array and the quartz controlled clock oscillator of the M48T35AY/V are integrated on one silicon chip. The two circuits are interconnected at the upper eight memory locations to provide user accessible BYTEWIDETM clock information in the bytes with addresses 7FF8h-7FFFh.

The clock locations contain the year, month, date, day, hour, minute, and second in 24 hour BCD format. Corrections for 28, 29 (leap year - valid until 2100), 30, and 31 day months are made automatically. Byte 7FF8h is the clock control register. This byte controls user access to the clock information and also stores the clock calibration setting.

The eight clock bytes are not the actual clock counters themselves; they are memory locations consisting of BiPORT[™] READ/WRITE memory

cells. The M48T35AY/V includes a clock control circuit which updates the clock bytes with current information once per second. The information can be accessed by the user in the same manner as any other location in the static memory array. The M48T35AY/V also has its own Power-fail Detect circuit. The control circuitry constantly monitors the single 3V supply for an out of tolerance condition. When V_{CC} is out of tolerance, the circuit write protects the SRAM, providing a high degree of data security in the midst of unpredictable system operation brought on by low V_{CC}. As V_{CC} falls below the Battery Back-up Switchover Voltage (V_{SO}) , the control circuitry connects the battery which maintains data and clock operation until valid power returns.

Mode	V _{CC}	E	G	w	DQ0-DQ7	Power
Deselect		VIH	Х	Х	High Z	Standby
WRITE	4.5 to 5.5V	V _{IL}	Х	V _{IL}	D _{IN}	Active
READ	or 3.0 to 3.6V	V _{IL}	V _{IL}	VIH	D _{OUT}	Active
READ		VIL	VIH	VIH	High Z	Active
Deselect	V_{SO} to V_{PFD} (min) ⁽¹⁾	Х	Х	Х	High Z	CMOS Standby
Deselect	$\leq V_{SO}^{(1)}$	Х	Х	Х	High Z	Battery Back-up Mode

Table 2. Operating Modes

Note: X = VIH or VIL; VSO = Battery Back-up Switchover Voltage.

1. See Table 11., page 18 for details.



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READ Mode

<u>The M48T35AY/V is in the READ</u> Mode whenever W (WRITE Enable) is high and E (Chip Enable) is low. The unique address specified by the 15 address inputs defines which one of the 32,768 bytes of data is to be accessed. Valid data will be available at the Data I/O pins within Address Access time (t_{AVQV}) after the last <u>address</u> input signal is stable, providing that the E and G access times are also satisfied.

If the \overline{E} and \overline{G} access times are not met, valid data will be available after the latter of the Chip Enable

Access time (t_{ELQV}) or Output Enable Access time (t_{GLQV}).

The state of the eight three-state Data I/O signals is controlled by E and G. If the outputs are activated before t_{AVQV} , the data lines will be driven to an indeterminate state until t_{AVQV} . If the Address Inputs are changed while E and G remain active, output data will remain valid for Output Data Hold time (t_{AXQX}) but will go indeterminate until the next Address Access.



Note: WRITE Enable (\overline{W}) = High.

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Table 3. READ	Mode AC	Characteristics
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		M48T	M48T35AY		35AV	
Symbol	Parameter ⁽¹⁾	-	70	-100		Unit
		Min	Max	Min	Max	
t _{AVAV}	READ Cycle Time	70		100		ns
tAVQV	Address Valid to Output Valid		70		100	ns
t _{ELQV}	Chip Enable Low to Output Valid		70		100	ns
t _{GLQV}	Output Enable Low to Output Valid		35		50	ns
t _{ELQX} ⁽²⁾	Chip Enable Low to Output Transition	5		10		ns
t _{GLQX} ⁽²⁾	Output Enable Low to Output Transition	5		5		ns
t _{EHQZ} ⁽²⁾	Chip Enable High to Output Hi-Z		25		50	ns
t _{GHQZ} ⁽²⁾	Output Enable High to Output Hi-Z		25		40	ns
t _{AXQX}	Address Transition to Output Transition	10		10		ns

Note: 1. Valid for Ambient Operating Temperature: $T_A = 0$ to 70°C or -40 to 85°C; $V_{CC} = 4.5$ to 5.5V or 3.0 to 3.6V (except where noted). 2. $C_L = 5pF$.

Figure 7. READ Mode AC Waveforms

WRITE Mode

The M48T35AY/V is in the WRITE Mode whenever W and E are low. The start of a WRITE is referenced from the latter occurring falling edge of W or E. A WRITE is terminated by the earlier rising edge of W or E. The addresses must be held valid throughout the cycle. E or W must return high for a minimum of t_{EHAX} from Chip Enable or t_{WHAX} from WRITE Enable prior to the initiation of anothermatical standards.

er READ or WRITE cycle. Data-in must be valid t_{D-VWH} prior to the end of WRITE and remain valid for t_{WHDX} afterward. G should be kept high during WRITE cycles to avoid bus contention; however, if the output bus has been activated by a low on E and <u>G</u>, a low on W will disable the outputs t_{WLQZ} after W falls.

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Figure 8. WRITE Enable Controlled, WRITE Mode AC Waveform







		M48T	35AY	M481	[35AV		
Symbol	Parameter ⁽¹⁾		70	-100		Unit	
		Min	Max	Min	Max		
t _{AVAV}	WRITE Cycle Time	70		100		ns	
t _{AVWL}	Address Valid to WRITE Enable Low	0		0		ns	
t _{AVEL}	Address Valid to Chip Enable Low	0		0		ns	
t _{WLWH}	WRITE Enable Pulse Width	50		80		ns	
tELEH	Chip Enable Low to Chip Enable High	55		80		ns	
t _{WHAX}	WRITE Enable High to Address Transition	0		10		ns	
t _{EHAX}	Chip Enable High to Address Transition	0		10		ns	
t _{DVWH}	Input Valid to WRITE Enable High	30		50		ns	
t _{DVEH}	Input Valid to Chip Enable High	30		50		ns	
tWHDX	WRITE Enable High to Input Transition	5		5		ns	
t _{EHDX}	Chip Enable High to Input Transition	5		5		ns	
t _{WLQZ} ^(2,3)	WRITE Enable Low to Output Hi-Z		25		50	ns	
t _{AVWH}	Address Valid to WRITE Enable High	60		80		ns	
t _{AVEH}	Address Valid to Chip Enable High	60		80		ns	
t _{WHQX} ^(2,3)	WRITE Enable High to Output Transition	5		10		ns	

Table 4. WRITE Mode AC Characteristics

Note: 1. Valid for Ambient Operating Temperature: T_A = 0 to 70°C or -40 to 85°C; V_{CC} = 4.5 to 5.5V or 3.0 to 3.6V (except where noted).
2. C_L = 5pF.
3. If E goes low simultaneously with W going low, the outputs remain in the high impedance state.

Data Retention Mode

With valid V_{CC} applied, the M48T35AY/V operates as a conventional BYTEWIDETM static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself when V_{CC} falls within the V_{PFD} (max), VPFD (min) window (see Figure 15, Table 10, and Table 11., page 18). All outputs become high impedance, and all inputs are treated as "don't care."

Note: A power failure during a WRITE cycle may corrupt data at the currently addressed location, but does not jeopardize the rest of the RAM's content. At voltages below V_{PFD} (min), the user can be assured the memory will be in a write protected state, provided the V_{CC} fall time is not less than t_F. The M48T35AY/V may respond to transient noise spikes on V_{CC} that reach into the deselect window during the time the device is sampling V_{CC}. Therefore, decoupling of the power supply lines is recommended.

When V_{CC} drops below V_{SO}, the control circuit switches power to the internal battery which preserves data and powers the clock. The internal button cell will maintain data in the M48T35AY/V for an accumulated period of at least 7 years when V_{CC} is less than V_{SO}. As system power returns and V_{CC} rises above V_{SO}, the battery is disconnected and the power supply is switched to external V_{CC}. Write protection continues until V_{CC} reaches V_{PFD} (min) plus t_{rec} (min). E should be kept high as V_{CC} rises past V_{PFD} (min) to prevent inadvertent WRITE cycles prior to processor stabilization. Normal RAM operation can resume t_{rec} after V_{CC} exceeds V_{PFD} (max).

Also, as V_{CC} rises, the battery voltage is checked. If the voltage is less tha<u>n</u> approximately 2.5V, an <u>internal</u> Battery Not OK (BOK) flag will be set. The <u>BOK</u> flag can be checked after power up. If the BOK flag is set, the first WRITE attempted will be blocked. The flag is automatically cleared after the first WRITE, and normal RAM<u>oper</u>ation resumes. Figure 10 illustrates how a BOK check routine could be structured.

For more information on Battery Storage Life refer to the Application Note AN1012.

Figure 10. Checking the BOK Flag Status



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CLOCK OPERATIONS

Reading the Clock

Updates to the TIMEKEEPER[®] registers (see Table 5) should be halted before clock data is read to prevent reading data in transition. The BiPORT[™] TIMEKEEPER cells in the RAM array are only data registers and not the actual clock counters, so updating the registers can be halted without disturbing the clock itself.

Updating is halted when a '1' is written to the READ Bit, D6 in the Control Register 7FF8h. As long as a '1' remains in that position, updating is halted.

After a halt is issued, the registers reflect the count; that is, the day, date, and the time that were current at the moment the halt command was issued.

All of the TIMEKEEPER registers are updated simultaneously. A halt will not interrupt an update in progress. Updating is within a second after the bit is reset to a '0.'

Setting the Clock

Bit D7 of the Control Register 7FF8h is the WRITE Bit. Setting the WRITE Bit to a '1,' like the READ Bit, halts updates to the TIMEKEEPER[®] registers. The user can then load them with the correct day, date, and time data in 24 hour BCD format (see Table 5). Resetting the WRITE Bit to a '0' then transfers the values of all time registers 7FF9h-7FFFh to the actual TIMEKEEPER counters and allows normal operation to resume. The FT Bit and the bits marked as '0' in Table 5 must be written to '0' to allow for normal TIMEKEEPER and RAM operation. After the WRITE Bit is reset, the next clock update will occur within one second.

See the Application Note AN923, "TIMEKEEPER[®] Rolling Into the 21st Century" for information on Century Rollover.

Stopping and Starting the Oscillator

The oscillator may be stopped at any time. If the device is going to spend a significant amount of time on the shelf, the oscillator can be turned off to minimize current drain on the battery. The STOP Bit is the MSB of the seconds register. Setting it to a '1' stops the oscillator. The M48T35AY/V is shipped from STMicroelectronics with the STOP Bit set to a '1.' When reset to a '0,' the M48T35AY/V oscillator starts within 1 second.

Address				Da	ata				Functio	n/Range Format		
Address	D7	D6	D5	D4	D3	D2	D1	D0				
7FFFh		10 Years			10 Years Year			Year			Year	00-99
7FFEh	0	0	0	10 M.		Month			Month	01-12		
7FFDh	0	0	10	10 Date		Date			Date	01-31		
7FFCh	0	FT	CEB	СВ	0	0 Day		Century/Day	00-01/01-07			
7FFBh	0	0	10 H	lours		Hours			Hours	00-23		
7FFAh	0		10 Minute	s		Minutes			Minutes	00-59		
7FF9h	ST	1	0 Second	ls	Seconds			Seconds	00-59			
7FF8h	W	R	S		(Calibration			Control			

Table 5. Register Map

Keys: S = SIGN Bit

FT = FREQUENCY TEST Bit (Must be set to '0' upon power for normal operation)

for normal o

R = READ Bit

W = WRITE Bit

ST = STOP Bit 0 = Must be set to '0' CEB = Century Enable Bit CB = Century Bit

Note: When CEB is set to '1,' CB will toggle from '0' to '1' or from '1' to '0' at the turn of the century (dependent upon the initial value set). When CEB is set to '0,' CB will not toggle. The WRITE Bit does not need to be set to write to CEB.

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Calibrating the Clock

The M48T35AY/V is driven by a quartz-controlled oscillator with a nominal frequency of 32,768 Hz. The devices are tested not to exceed 35 ppm (parts per million) oscillator frequency error at 25°C, which equates to about ± 1.53 minutes per month. With the calibration bits properly set, the accuracy of each M48T35AY/V improves to better than $\pm 1/-2$ ppm at 25°C.

The oscillation rate of any crystal changes with temperature (see Figure 11., page 13). Most clock chips compensate for crystal frequency and temperature shift error with cumbersome "trim" capacitors. The M48T35AY/V design, however, employs periodic counter correction. The calibration circuit adds or subtracts counts from the oscillator divider circuit at the divide by 256 stage, as shown in Figure 12., page 13. The number of times pulses are blanked (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in the Control Register. Adding counts speeds the clock up, subtracting counts slows the clock down.

The Calibration Byte occupies the five lower order bits (D4-D0) in the Control Register 7FF8h. These bits can be set to represent any value between 0 and 31 in binary form. Bit D5 is the Sign Bit; '1' indicates positive calibration, '0' indicates negative calibration. Calibration occurs within a 64 minute cycle. The first 62 minutes in the cycle may, once per minute, have one second either shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first 2 minutes in the 64 minute cycle will be modified; if a binary 6 is loaded, the first 12 will be affected, and so on.

Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is +4.068 or -2.034 ppm of adjustment per calibration step in the calibration register. Assuming that the oscillator is in fact running at exactly 32,768 Hz, each of the 31 increments in the Calibration Byte would represent +10.7 or -5.35 seconds per

month which corresponds to a total range of +5.5 or -2.75 minutes per month.

Two methods are available for ascertaining how much calibration a given M48T35AY/V may require. The first involves simply setting the clock, letting it run for a month and comparing it to a known accurate reference (like WWV broadcasts). While that may seem crude, it allows the designer to give the end user the ability to calibrate his clock as his environment may require, even after the final product is packaged in a non-user serviceable enclosure.

The second approach is better suited to a manufacturing environment, and involves the use of some test equipment. When the Frequency Test (FT) Bit, the seventh-most significant bit in the Day Register is set to a '1,' and D7 of the Seconds Register is a '0' (Oscillator Running), DQ0 will toggle at 512 Hz during a READ of the Seconds Register. Any deviation from 512 Hz indicates the degree and direction of oscillator frequency shift at the test temperature. For example, a reading of 512.01024 Hz would indicate a +20 ppm oscillator frequency error, requiring a -10 (WR001010) to be loaded into the Calibration Byte for correction.

Note: Setting or changing the Calibration Byte does not affect the Frequency Test output frequency.

The FT Bit MUST be reset to '0' for normal clock operations to resume. The FT Bit is automatically Reset on power-down.

For more information on calibration, see Application Note AN934, "TIMEKEEPER[®] Calibration."

Century Bit

Bit D5 and D4 of Clock Register 7FFCh contain the CENTURY ENABLE Bit (CEB) and the CEN-TURY Bit (CB). Setting CEB to a '1' will cause CB to toggle, either from a '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0,' CB will not toggle.

Note: The WRITE Bit must be set in order to write to the CENTURY Bit.

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Figure 12. Clock Calibration



V_{CC} Noise And Negative Going Transients

 I_{CC} transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the V_{CC} bus. These transients can be reduced if capacitors are used to store energy which stabilizes the V_{CC} bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A bypass capacitor value of 0.1µF (as shown in Figure 13) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on V_{CC} that drive it to values below V_{SS} by as much as one volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, it is recommended to connect a schottky diode from V_{CC} to V_{SS} (cathode connected to V_{CC}, anode to V_{SS}). Schottky diode 1N5817 is recommended for through hole and MBRS120T3 is recommended for surface mount.

Figure 13. Supply Voltage Protection



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MAXIMUM RATING

Stressing the device above the rating listed in the "Absolute Maximum Ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is

not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Parameter	Value	Unit	
Ambient Operating Temperature	Grade 1	0 to 70	°C
Ambient Operating Temperature	Grade 6	-40 to 85	°C
Storage Temperature (V _{CC} Off, Oscillator Off)	-40 to 85	°C
Lead Solder Temperature for 10 seconds	260	°C	
VID Input or Output Voltages	M48T35AY	-0.3 to 7	V
input of Output voltages	M48T35AV	-0.3 to 4.6	V
Supply Voltage	M48T35AY	-0.3 to 7	V
V _{CC} Supply Voltage		-0.3 to 4.6	V
Output Current		20	mA
Power Dissipation	1	W	
	Ambient Operating Temperature Storage Temperature (V _{CC} Off, Oscillator Off Lead Solder Temperature for 10 seconds Input or Output Voltages Supply Voltage Output Current	Ambient Operating Temperature Grade 1 Grade 6 Grade 6 Storage Temperature (V _{CC} Off, Oscillator Off) Lead Solder Temperature for 10 seconds Input or Output Voltages M48T35AY M48T35AV Supply Voltage M48T35AY Output Current M48T35AV	Ambient Operating TemperatureGrade 10 to 70Ambient Operating TemperatureGrade 6-40 to 85Storage Temperature (V _{CC} Off, Oscillator Off)-40 to 85Lead Solder Temperature for 10 seconds260Input or Output VoltagesM48T35AY-0.3 to 7M48T35AV-0.3 to 7M48T35AV-0.3 to 4.6Supply VoltageM48T35AV-0.3 to 7Output Current2020

Note: 1. For DIP package: Soldering temperature not to exceed 260°C for 10 seconds (total thermal budget not to exceed 150°C for longer than 30 seconds).

2. For SO package, standard (SnPb) lead finish: Reflow at peak temperature of 225°C (total thermal budget not to exceed 180°C for

between 90 to 150 seconds). 3. For SO package, Lead-free (Pb-free) lead finish: Reflow at peak temperature of 260°C (total thermal budget not to exceed 245°C for greater than 30 seconds).

CAUTION: Negative undershoots below -0.3V are not allowed on any pin while in the Battery Back-up mode. CAUTION: Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.

DC AND AC PARAMETERS

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC Characteristic tables are derived from tests performed under the Measurement Conditions listed in the relevant tables. Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 7. Operating and AC Measurement Conditions

Parameter	M48T35AY	M48T35AV	Unit	
Supply Voltage (V _{CC})		4.5 to 5.5	3.0 to 3.6	V
Ambient Operating Temperature (T _A)	Grade 1	0 to 70	0 to 70	°C
	Grade 6	-40 to 85	-40 to 85	
Load Capacitance (CL)		100	50	pF
Input Rise and Fall Times		≤ 5	≤ 5	ns
Input Pulse Voltages		0 to 3	0 to 3	V
Input and Output Timing Ref. Voltages		1.5	1.5	V

Note: Output Hi-Z is defined as the point where data is no longer driven.

Figure 14. AC Measurement Load Circuit



Note: 50pF for M48T35AV.

Table 8. Capacitance

Symbol	Parameter ^(1,2)	Min	Max	Unit
C _{IN}	Input Capacitance		10	pF
C _{OUT} ⁽³⁾	Output Capacitance		10	pF

Note: 1. Effective capacitance measured with power supply at 5V; sampled only, not 100% tested.

2. At 25°C, f = 1MHz.

3. Outputs deselected.



			M481	35AY	M48T	35AV		
Symbol	Parameter	Test Condition ⁽¹⁾	-	70	-100		Unit	
			Min	Max	Min	Max		
ILI	Input Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		±1		±1	μA	
I _{LO} ⁽²⁾	Output Leakage Current	$0V \leq V_{OUT} \leq V_{CC}$		±1		±1	μA	
Icc	Supply Current	Outputs open		50		30	mA	
I _{CC1}	Supply Current (Standby) TTL	$\overline{E} = V_{IH}$		3		2	mA	
I _{CC2}	Supply Current (Standby) CMOS	$\overline{E} = V_{CC} - 0.2V$		3		2	mA	
V _{IL} (3)	Input Low Voltage		-0.3	0.8	-0.3	0.8	V	
VIH	Input High Voltage		2.2	$V_{CC} + 0.3$	2.2	V _{CC} + 0.3	V	
V _{OL}	Output Low Voltage	I _{OL} = 2.1mA		0.4		0.4	V	
V _{OH}	Output High Voltage	I _{OH} = -1mA	2.4		2.4		V	

Table 9. DC Characteristics

Note: 1. Valid for Ambient Operating Temperature: T_A = 0 to 70°C or -40 to 85°C; V_{CC} = 4.5 to 5.5V or 3.0 to 3.6V (except where noted).
2. Outputs deselected.
3. Negative spikes of -1V allowed for up to 10ns once per Cycle.

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Figure 15. Power Down/Up Mode AC Waveforms

Table 10. Power Down/Up AC Characteristics

Symbol	Parameter ⁽¹⁾	Min	Max	Unit	
t _{PD}	\overline{E} or \overline{W} at V _{IH} before Power Down		0		μs
t _F ⁽²⁾	V_{PFD} (max) to V_{PFD} (min) V_{CC} Fall Time	300		μs	
t _{FB} ⁽³⁾	V _{PFD} (min) to V _{SS} V _{CC} Fall Time	M48T35AY	10		μs
^t FB ⁽⁰⁾	M48T35		150		μs
t _R	V_{PFD} (min) to V_{PFD} (max) V_{CC} Rise Time		10		μs
t _{RB}	V_{SS} to V_{PFD} (min) V_{CC} Rise Time	1		μs	
t _{rec} ⁽⁴⁾	V _{PFD} (max) to Inputs Recognized	40	200	ms	

Note: 1. Valid for Ambient Operating Temperature: $T_A = 0$ to 70°C or -40 to 85°C; $V_{CC} = 4.5$ to 5.5V or 3.0 to 3.6V (except where noted). 2. V_{PFD} (max) to V_{PFD} (min) fall time of less than t_F may result in deselection/write protection not occurring until 200µs after V_{CC} passes V_{PFD} (min).

3. VPFD (min) to VSS fall time of less than tFB may cause corruption of RAM data.

4. t_{rec} (min) = 20ms for industrial temperature Grade 6 device.

Table 11. Power Down/Up Trip Points DC Characteristics

Symbol	Parameter ^(1,2)		Min	Тур	Max	Unit
Vara	Power fail Decelect Veltage	M48T35AY	4.2	4.35	4.5	V
V PFD	V _{PFD} Power-fail Deselect Voltage	M48T35AV	2.7	2.9	3.0	V
Vee	Pottory Pools up Switchover Veltage	M48T35AY		3.0		V
V SO	V _{SO} Battery Back-up Switchover Voltage	M48T35AV		V _{PFD} –100mV		V
t _{DR} ⁽⁵⁾	Expected Data Retention Time	Grade 1	10 ⁽³⁾			YEARS
'DR'		Grade 6	10 ⁽⁴⁾			YEARS

Note: 1. Valid for Ambient Operating Temperature: $T_A = 0$ to 70°C or -40 to 85°C; $V_{CC} = 4.5$ to 5.5V or 3.0 to 3.6V (except where noted).

2. All voltages referenced to V_{SS} .

4. Using larger M4T32-BR12SH6 SNAPHAT top (recommended for Industrial Temperature Range - Grade 6 device).

5. At 25°C, V_{CC} = 0V.



^{3.} CAPHAT and M4T32-BR12SH1 SNAPHAT only, M4T28-BR12SH1 SNAPHAT top t_{DR} = 7 years (typ).

PACKAGE MECHANICAL INFORMATION



Figure 16. PCDIP28 – 28-pin Plastic DIP, battery CAPHAT™, Package Outline

Note: Drawing is not to scale.

Table 12. PCDIP28 – 28-pin Plastic DIP, battery CAPHAT™, Package Mechanical Data

Symph		mm		inches			
Symb	Symb Typ Min Max Ty		Тур	Min	Max		
А		8.89	9.65		0.350	0.380	
A1		0.38	0.76		0.015	0.030	
A2		8.38	8.89		0.330	0.350	
В		0.38	0.53		0.015	0.021	
B1		1.14	1.78		0.045	0.070	
С		0.20	0.31		0.008	0.012	
D		39.37	39.88		1.550	1.570	
Е		17.83	18.34		0.702	0.722	
e1		2.29	2.79		0.090	0.110	
e3		29.72	36.32		1.170	1.430	
eA		15.24	16.00		0.600	0.630	
L		3.05	3.81		0.120	0.150	
Ν		28	•		28	•	



Figure 17. SOH28 – 28-lead Plastic Small Outline, 4-socket battery SNAPHAT, Package Outline

Note: Drawing is not to scale.

Table 13. SOH28 – 28-lead Plastic Small Outline, 4-socket battery SNAPHAT, Pack. Mech. Data

<u>Cumh</u>		mm			inches	
Symb	Тур	Min	Max	Тур	Min	Max
А			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
В		0.36	0.51		0.014	0.020
С		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
Е		8.23	8.89		0.324	0.350
е	1.27	-	-	0.050	-	-
eB		3.20	3.61		0.126	0.142
Н		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
α		0°	8°		0°	8°
Ν		28	•		28	
СР			0.10			0.004



Figure 18. SH – 4-pin SNAPHAT Housing for 48mAh Battery & Crystal, Package Outline

Note: Drawing is not to scale.

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Table 14. SH – 4-pin SNAPHAT Housing for 48mAh Battery & Crystal, Package Mech. Data

Symb	Symb		mm		inches		
Symb	Тур	Min	Мах	Тур	Min	Max	
A			9.78			0.385	
A1		6.73	7.24		0.265	0.285	
A2		6.48	6.99		0.255	0.275	
A3			0.38			0.015	
В		0.46	0.56		0.018	0.022	
D		21.21	21.84		0.835	0.860	
E		14.22	14.99		0.560	0.590	
eA		15.55	15.95		0.612	0.628	
eB		3.20	3.61		0.126	0.142	
L		2.03	2.29		0.080	0.090	



Figure 19. SH – 4-pin SNAPHAT Housing for 120mAh Battery & Crystal, Package Outline

Note: Drawing is not to scale.

Table 15. SH – 4-pin SNAPHAT Housing for 120mAh Battery & Crystal, Package Mech. Data

Symb	Symb		mm		inches		
Symb	Тур	Min	Max	Тур	Min	Max	
A			10.54			0.415	
A1		8.00	8.51		0.315	0.335	
A2		7.24	8.00		0.285	0.315	
A3			0.38			0.015	
В		0.46	0.56		0.018	0.022	
D		21.21	21.84		0.835	0.860	
E		17.27	18.03		0.680	0.710	
eA		15.55	15.95		0.612	0.628	
eB		3.20	3.61		0.126	0.142	
L		2.03	2.29		0.080	0.090	

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PART NUMBERING

Table 16. Ordering Information Scheme

Example:	M48T	35AY	-70	МН	1	Е
Device Туре						
M48T	<u>.</u>					
Supply Voltage and Write Protect Voltage						
$35AY = V_{CC} = 4.5$ to 5.5V; $V_{PFD} = 4.2$ to 4.5V						
35AV = V_{CC} = 3.0 to 3.6V; V_{PFD} = 2.7 to 3.0V						
Speed						
-70 = 70ns (35AY)			<u> </u>			
−10 = 100ns (35AV)						
Package						
PC = PCDIP28						
$MH^{(1)} = SOH28$						
Temperature Range						
1 = 0 to 70°C						
$6 = -40$ to $85^{\circ}C^{(2)}$						
Shipping Method						

For SOH28:

blank = Tubes (Not for New Design - Use E)

E = Lead-free Package (ECO PACK[®]), Tubes

F = Lead-free Package (ECO PACK[®]), Tape & Reel

TR = Tape & Reel (Not for New Design - Use F)

For PCDIP28:

blank = Tubes

- Note: 1. The SOIC package (SOH28) requires the SNAPHAT[®] battery package which is ordered separately under the part number "M4TXX-BR12SH" in plastic tube or "M4TXX-BR12SHTR" in Tape & Reel form (see Table 17).
 - 2. Available in SOIC package only.

Caution: Do not place the SNAPHAT battery package "M4TXX-BR12SH" in conductive foam as it will drain the lithium button-cell battery.

For other options, or for more information on any aspect of this device, please contact the ST Sales Office nearest you.

Part Number	Description	Package
M4T28-BR12SH	Lithium Battery (48mAh) SNAPHAT	SH
M4T32-BR12SH	Lithium Battery (120mAh) SNAPHAT	SH

Table 17. SNAPHAT Battery Table

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REVISION HISTORY

Table 18. Document Revision History

Date	Rev. #	Revision Details
November 1999	1.0	First Issue
21-Apr-00	2.0	From Preliminary Data to Data Sheet
29-May-00	2.1	t _{FB} change (Table 10)
20-Jul-01	3.0	Reformatted; temp./voltage info. added to tables (Table 8, 9, 3, 4, 10, 11); add Century Bit text
20-May-02	3.1	Modify reflow time and temperature footnotes (Table 6)
31-Mar-03	4.0	v2.2 template applied; data retention condition updated (Table 11)
01-Apr-04	5.0	Reformatted; updated with Lead-free package information (Table 6, 16)



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